Application/Control No.	Applicant(s)/Patent under Reexamination	
10/623,199	GROS ET AL.	
Examiner	Art Unit	
Gopal C. Ray	2111	

SEARCHED					
Class	Subclass	Date	Examiner		
710	305,105,1 5	10/11/2005	GCR		
709	224,217	10/11/2005	GCR		
709	249	10/11/2005	GCR		
370	245,252	10/11/2005	GCR		
370	451	10/11/2005	GCR		
713	153,154	10/11/2005	GCR		
702	122,190	10/11/2005	GCR		
714	47,799	10/11/2005	GCR		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
WEST: USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDB (see search history printouts)	10/11/2005	GCR		
EAST: USPT (see search history printouts)	10/11/2005	GCR		
NPL: IEEE Xplore (see search history printouts)	10/11/2005	GCR		
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